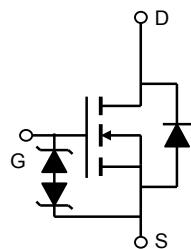
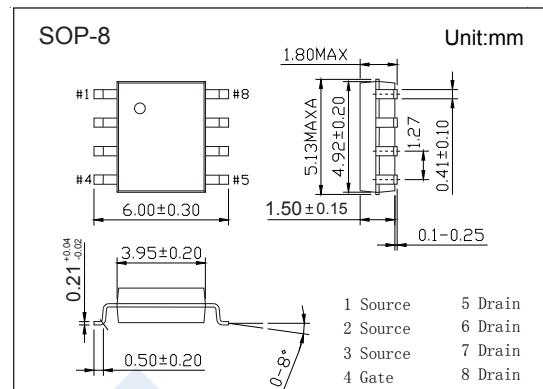


N-Channel MOSFET

AO4480 (KO4480)

■ Features

- $V_{DS} (V) = 40V$
- $I_D = 14 A (V_{GS} = 10V)$
- $R_{DS(ON)} < 11.5m\Omega (V_{GS} = 10V)$
- $R_{DS(ON)} < 15.5m\Omega (V_{GS} = 4.5V)$
- ESD Rating: 4KV HBM



■ Absolute Maximum Ratings $T_a = 25^\circ C$

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	40	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current	I_D	14	A
		11	
Pulsed Drain Current	I_{DM}	70	
Avalanche Current	I_{AR}	30	
Repetitive Avalanche Energy	E_{AR}	135	mJ
Power Dissipation	P_D	3.1	W
		2	
Thermal Resistance.Junction- to-Ambient	R_{thJA}	40	$^\circ C/W$
		75	
Thermal Resistance.Junction- to-Lead	R_{thJL}	24	
Junction Temperature	T_J	150	
Storage Temperature Range	T_{stg}	-55 to 150	$^\circ C$

N-Channel MOSFET

AO4480 (KO4480)

■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V _{DSS}	I _D =250 μ A, V _{GS} =0V	40			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =32V, V _{GS} =0V			1	uA
		V _{DS} =32V, V _{GS} =0V, T _J =55°C			5	
Gate-Body Leakage Current	I _{GSS}	V _{DS} =0V, V _{GS} =±20V			±100	uA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250uA	1		3	V
Static Drain-Source On-Resistance	R _{Ds(on)}	V _{GS} =10V, I _D =14A			11.5	mΩ
		V _{GS} =10V, I _D =14A T _J =125°C			13	
		V _{GS} =4.5V, I _D =5A			15.5	
On State Drain Current	I _{D(ON)}	V _{GS} =10V, V _{DS} =5V	70			A
Forward Transconductance	g _{FS}	V _{DS} =5V, I _D =5A	50			S
Input Capacitance	C _{iss}	V _{GS} =0V, V _{DS} =20V, f=1MHz		1600	1920	pF
Output Capacitance	C _{oss}			320		
Reverse Transfer Capacitance	C _{rss}			100		
Gate Resistance	R _g	V _{GS} =0V, V _{DS} =0V, f=1MHz		3.4		Ω
Total Gate Charge (10V)	Q _g	V _{GS} =10V, V _{DS} =20V, I _D =14A		22		nC
Total Gate Charge (4.5V)				10.5		
Gate Source Charge	Q _{gs}			4.2		
Gate Drain Charge	Q _{gd}			4.8		
Turn-On DelayTime	t _{d(on)}	V _{GS} =10V, V _{DS} =20V, R _L =1.5Ω, R _{GEN} =3Ω		3.5		ns
Turn-On Rise Time	t _r			6		
Turn-Off DelayTime	t _{d(off)}			13.2		
Turn-Off Fall Time	t _f			3.5		
Body Diode Reverse Recovery Time	t _{rr}	I _F = 14A, d _I /d _t = 100A/us		31		nC
Body Diode Reverse Recovery Charge	Q _{rr}			33		
Maximum Body-Diode Continuous Current	I _s				4	A
Diode Forward Voltage	V _{SD}	I _s =1A, V _{GS} =0V			1	V

Note : The static characteristics in Figures 1 to 6 are obtained using <300 us pulses, duty cycle 0.5% max.

■ Marking

Marking	4480 KC****
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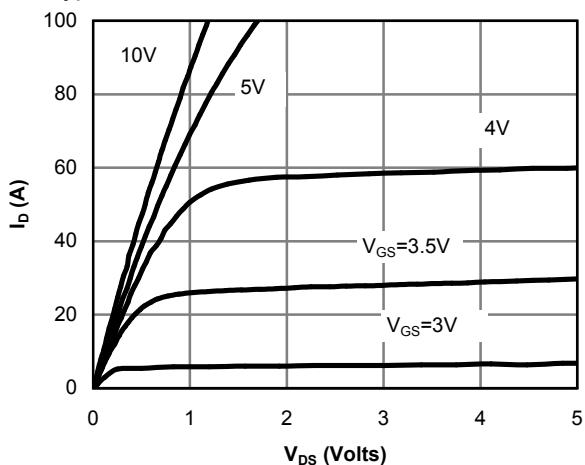
N-Channel MOSFET**AO4480 (KO4480)****■ Typical Characteristics**

Figure 1: On-Region Characteristics

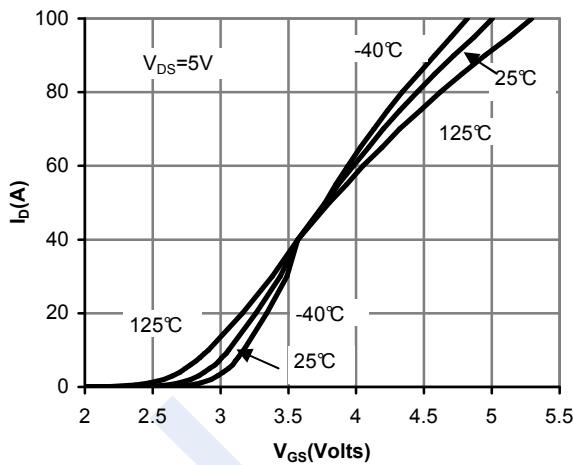


Figure 2: Transfer Characteristics

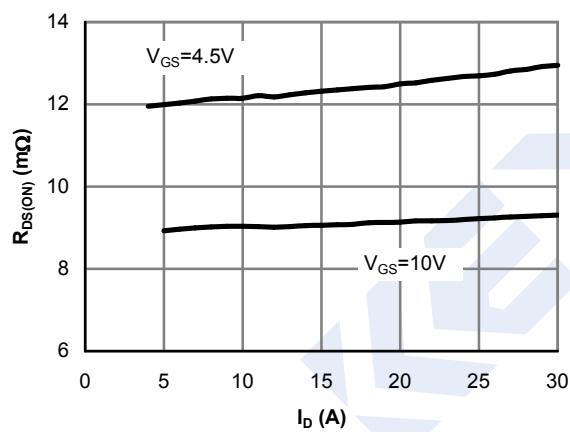


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

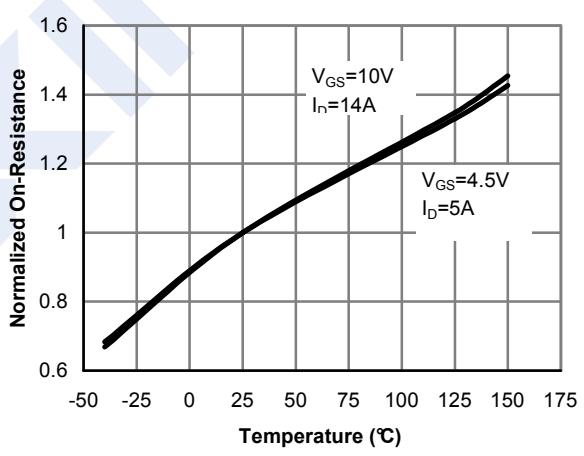


Figure 4: On-Resistance vs. Junction Temperature

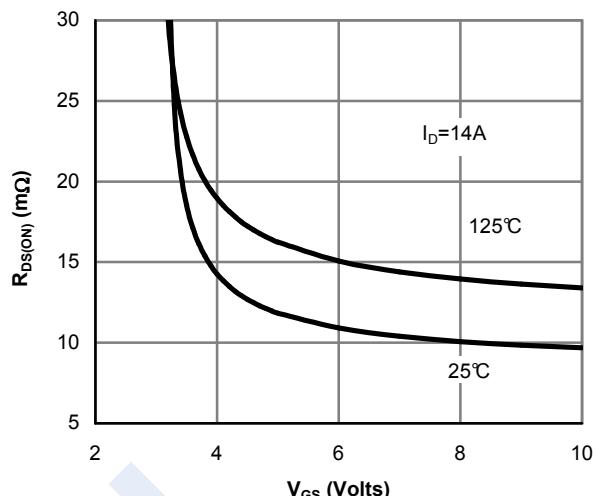


Figure 5: On-Resistance vs. Gate-Source Voltage

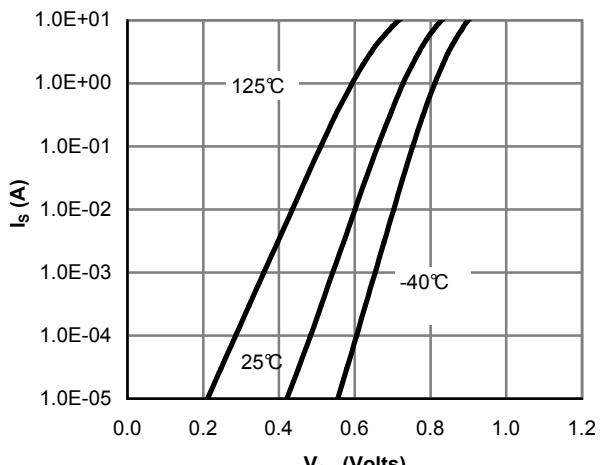


Figure 6: Body-Diode Characteristics

N-Channel MOSFET

AO4480 (KO4480)

■ Typical Characteristics

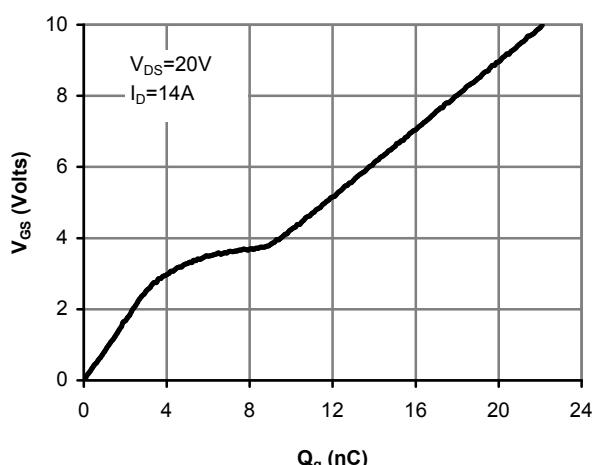


Figure 7: Gate-Charge Characteristics

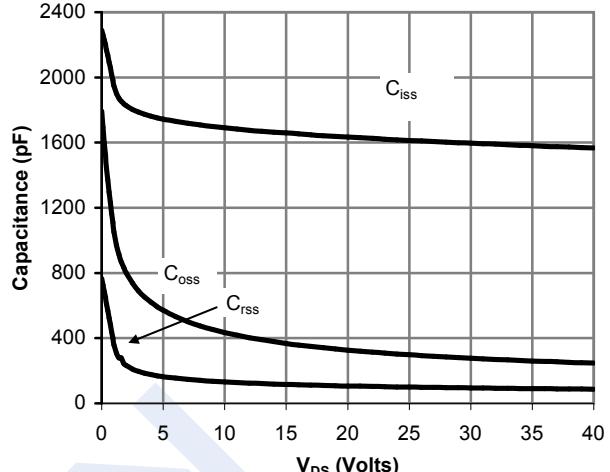


Figure 8: Capacitance Characteristics

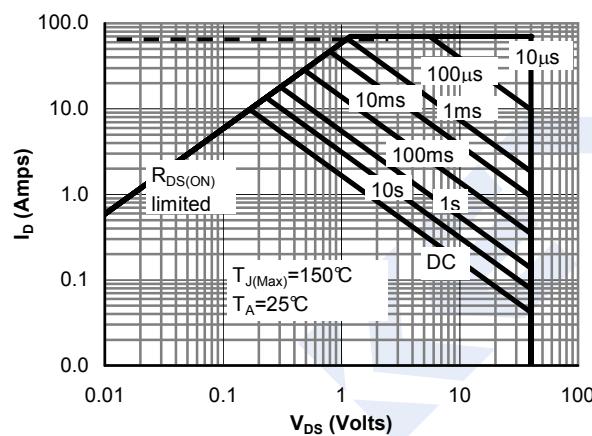


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

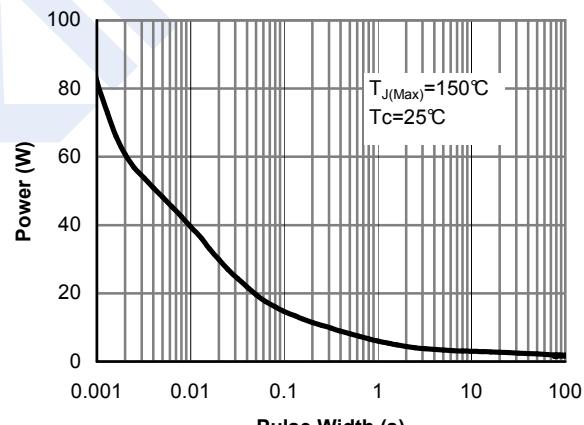


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

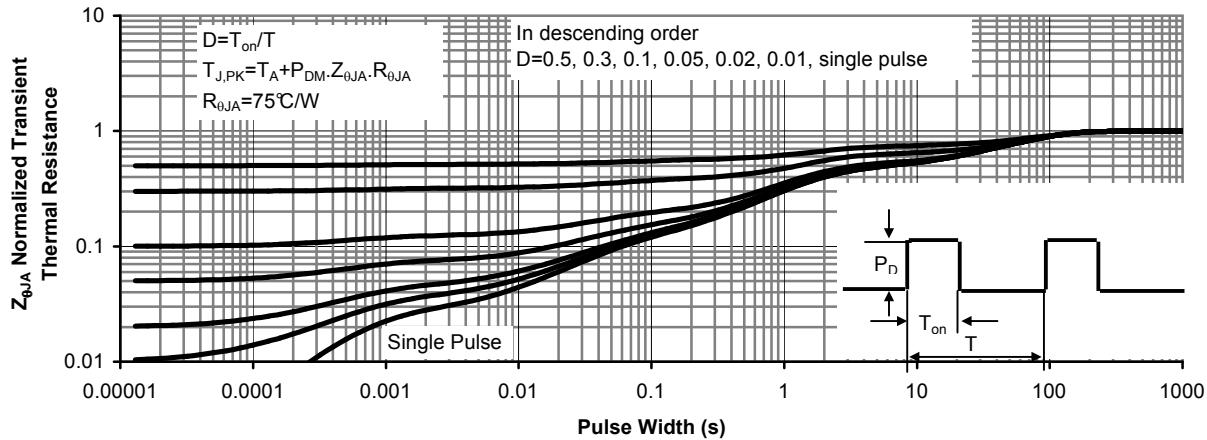


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)